

**Notice of References Cited**

Application/Control No.

09/685,772

Applicant(s)/Patent Under  
Reexamination  
BLAESING-BANGERT ET AL.

Examiner

Michelle Nguyen

Art Unit

2851

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

FORM PTO-1449 U.S. Department of Commerce Patent & Trademark Office  <b>INFORMATION DISCLOSURE STATEMENT</b> <i>(Use several sheets if necessary)</i>	Attorney Docket No. 038664.49301US	Serial No. 09/685,772
	Applicant: Carola Blaesing-Bangert, et. al.	
	Filing Date October 11, 2000	Group 2851

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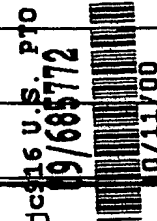
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**INFORMATION DISCLOSURE STATEMENT**  
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